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July 2014

FDMA2002NZ

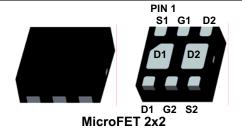
Dual N-Channel PowerTrench® MOSFET

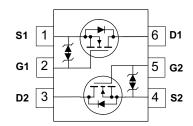
General Description

This device is designed specifically as a single package solution for dual switching requirements in cellular handset and other ultra-portable applications. It features two independent N-Channel MOSFETs with low on-state resistance for minimum conduction losses. The MicroFET 2x2 offers exceptional thermal performance for its physical size and is well suited to linear mode applications.

Features

- Low profile 0.8 mm maximum in the new package MicroFET 2x2 mm
- HBM ESD protection level = 1.8kV (Note 3)
- RoHS Compliant
- Free from halogenated compounds and antimony oxides





Absolute Maximum Ratings T_A=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units	
V _{DS}	Drain-Source Voltage		30	V	
V _{GS}	Gate-Source Voltage		±12	V	
I _D	Drain Current – Continuous (T _C = 25°C, V _{GS} = 4.5V)		2.9		
	- Continuous ($T_C = 25^{\circ}C$, $V_{GS} = 2.5V$)		2.7	Α	
	- Pulsed		10	1	
P _D	Power Dissipation for Single Operation ((Note 1a)	1.5	147	
	Power Dissipation for Single Operation ((Note 1b)	0.65	W	
T _J , T _{STG}	Operating and Storage Temperature		-55 to +150	°C	

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	83 (Single Operation)	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1b)	193 (Single Operation)	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1c)	68 (Dual Operation)	*C/VV
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1d)	145 (Dual Operation)	

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
002	FDMA2002NZ	7"	8mm	3000 units

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Symbol	Parameter	Test Conditions	Min	Tvp	Max	Units		
-		1 1001 001141110110	1	- 710				
	acteristics	To a second	T	1	1			
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \qquad I_{D} = 250 \mu\text{A}$	30			V		
<u>ΔBV_{DSS}</u> ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 25°C		25		mV/°C		
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 24 \text{ V}, \qquad V_{GS} = 0 \text{ V}$			1	μΑ		
I_{GSS}	Gate–Body Leakage Current	$V_{GS} = \pm 12 \text{ V}, V_{DS} = 0 \text{ V}$			±10	μΑ		
On Char	acteristics							
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	0.4	1.0	1.5	V		
$\frac{\Delta V_{GS(th)}}{\Delta T_{,J}}$	Gate Threshold Voltage Temperature Coefficient	I_D = 250 μ A, Referenced to 25°C		-3		mV/°C		
		V _{GS} = 4.5V, I _D = 2.9A		75	123			
R _{DS(on)} Static Drain–Source On–Resistance		V _{GS} = 3.0V, I _D = 2.7A		84	140			
		$V_{GS} = 2.5V, I_D = 2.5A$		92	163	mΩ		
		$V_{GS} = 4.5V$, $I_D = 2.9A$, $T_C = 85^{\circ}C$		95	166	11152		
		$V_{GS} = 3.0V, I_D = 2.7A, T_C = 150^{\circ}C$		138	203			
		$V_{GS} = 2.5V, I_D = 2.5A, T_C = 150^{\circ}C$		150	268	8		
	Characteristics Input Capacitance	Tu ten u ou	1	190	220	nE		
Ciss	 	$V_{DS} = 15 \text{ V}, \qquad V_{GS} = 0 \text{ V},$ f = 1.0 MHz		30	40	pF		
C _{oss}	Output Capacitance Reverse Transfer Capacitance	1 - 1:0 MH2		20	30	pF pF		
	•				30	Ρ.		
Switchin	g Characteristics (Note 2)							
Switchin t _{d(on)}	G Characteristics (Note 2) Turn-On Delay Time	$V_{DD} = 15 \text{ V}, I_D = 1 \text{ A},$ $V_{CD} = 4.5 \text{ V}, P_{DD} = 6.0$		6	12	ns		
Switchin t _{d(on)} t _r	Turn-On Rise Time	$V_{DD} = 15 \text{ V}, \qquad I_D = 1 \text{ A},$ $V_{GS} = 4.5 \text{ V}, \qquad R_{GEN} = 6 \Omega$		6 8	12	ns ns		
Switchin t _{d(on)} t _r t _{d(off)}	Turn-On Rise Time Turn-Off Delay Time			6 8 12	12 16 21	ns ns ns		
$\begin{array}{c} \textbf{Switchin} \\ \textbf{t}_{d(on)} \\ \textbf{t}_{r} \\ \textbf{t}_{d(off)} \\ \textbf{t}_{f} \end{array}$	Turn-Off Fall Time Turn-Off Fall Time	V_{GS} = 4.5 V, R_{GEN} = 6 Ω		6 8 12 2	12 16 21 10	ns ns ns		
$\begin{array}{c} \textbf{Switchin} \\ \textbf{t}_{d(on)} \\ \textbf{t}_{r} \\ \textbf{t}_{d(off)} \\ \textbf{t}_{f} \\ \textbf{Q}_{g} \end{array}$	Turn-Off Fall Time Total Gate Charge	$V_{GS} = 4.5 \text{ V}, \qquad R_{GEN} = 6 \Omega$ $V_{DS} = 15 \text{ V}, \qquad I_D = 2.9 \text{ A},$		6 8 12 2 2.4	12 16 21	ns ns ns ns		
$\begin{array}{c} \textbf{Switchin} \\ \textbf{t}_{d(on)} \\ \textbf{t}_{r} \\ \textbf{t}_{d(off)} \\ \textbf{t}_{f} \end{array}$	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge	V_{GS} = 4.5 V, R_{GEN} = 6 Ω		6 8 12 2 2.4 0.35	12 16 21 10	ns ns ns ns nC		
$\begin{array}{c} \textbf{Switchin} \\ \textbf{t}_{d(on)} \\ \textbf{t}_{r} \\ \textbf{t}_{d(off)} \\ \textbf{t}_{f} \\ \textbf{Q}_{g} \end{array}$	Turn-Off Fall Time Total Gate Charge	$V_{GS} = 4.5 \text{ V}, \qquad R_{GEN} = 6 \Omega$ $V_{DS} = 15 \text{ V}, \qquad I_D = 2.9 \text{ A},$		6 8 12 2 2.4	12 16 21 10	ns ns ns ns		
$\begin{array}{c} \textbf{Switchin} \\ \textbf{t}_{d(on)} \\ \textbf{t}_r \\ \textbf{t}_{d(off)} \\ \textbf{t}_f \\ \textbf{Q}_g \\ \textbf{Q}_{gs} \\ \textbf{Q}_{gd} \\ \end{array}$	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge Durce Diode Characteristics	$V_{GS} = 4.5 \text{ V}, \qquad R_{GEN} = 6 \ \Omega$ $V_{DS} = 15 \text{ V}, \qquad I_D = 2.9 \text{ A},$ $V_{GS} = 4.5 \text{ V}$ and Maximum Ratings		6 8 12 2 2.4 0.35	12 16 21 10 3.0	ns ns ns ns nC		
Switchin t _{d(on)} t _r t _{d(off)} t _t Q _g Q _{gs} Q _{gd} Drain—So	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Drain Charge	$V_{GS} = 4.5 \text{ V}, \qquad R_{GEN} = 6 \ \Omega$ $V_{DS} = 15 \text{ V}, \qquad I_D = 2.9 \text{ A},$ $V_{GS} = 4.5 \text{ V}$ and Maximum Ratings		6 8 12 2 2.4 0.35	12 16 21 10	ns ns ns ns nC		
Switchin t _{d(on)} t _r t _{d(off)} t _t Q _g Q _{gs} Q _{gd} Drain—So	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge Durce Diode Characteristics	V_{GS} = 4.5 V, R_{GEN} = 6 Ω V_{DS} = 15 V, I_{D} = 2.9 A, V_{GS} = 4.5 V and Maximum Ratings n Diode Forward Current I_{S} = 2.0 A		6 8 12 2 2.4 0.35 0.75	12 16 21 10 3.0	ns ns ns ns nC nC		
$\begin{array}{c} \textbf{Switchin} \\ \textbf{t}_{d(\text{on})} \\ \textbf{t}_r \\ \textbf{t}_{d(\text{off})} \\ \textbf{t}_f \\ \textbf{Q}_g \\ \textbf{Q}_{gs} \\ \textbf{Q}_{gd} \\ \end{array}$	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge Maximum Continuous Source-Drain Source-Drain Diode Forward	V_{GS} = 4.5 V, R_{GEN} = 6 Ω V_{DS} = 15 V, I_{D} = 2.9 A, V_{GS} = 4.5 V and Maximum Ratings n Diode Forward Current		6 8 12 2 2.4 0.35 0.75	12 16 21 10 3.0 2.9	ns ns ns ns nC nC nC		

- 1. $R_{\theta JA}$ is determined with the device mounted on a 1 in² oz. copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta JA}$ is determined by the user's board design.

 (a) $R_{\theta JA} = 86$ °C/W when mounted on a 1 in² pad of 2 oz copper, 1.5 " x 1.5 " x 0.062" thick PCB. For single operation.

 - (b) $R_{\theta JA}$ = 173 °C/W when mounted on a minimum pad of 2 oz copper. For single operation.
 - (c) $R_{\theta JA}$ = 69 °C/W when mounted on a 1 in² pad of 2 oz copper, 1.5 " x 1.5 " x 0.062 " thick PCB. For dual operation.
 - (d) $R_{\theta JA}$ = 151 °C/W when mounted on a minimum pad of 2 oz copper. For dual operation.



- 2. Pulse Test : Pulse Width < 300 us, Duty Cycle < 2.0%
- 3. The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

Typical Characteristics

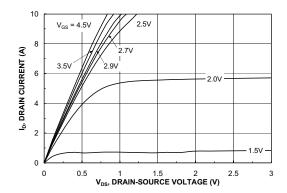


Figure 1. On-Region Characteristics.

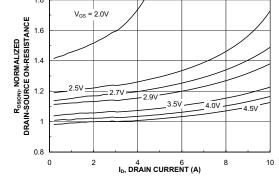


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

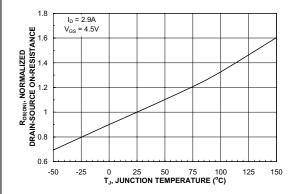


Figure 3. On-Resistance Variation with Temperature.

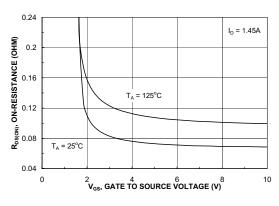


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

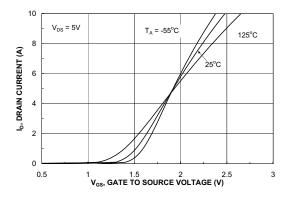


Figure 5. Transfer Characteristics.

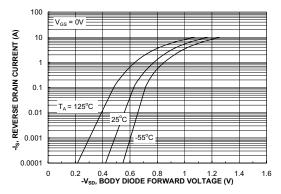
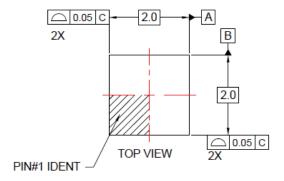
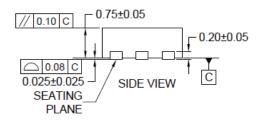
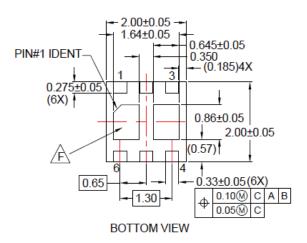


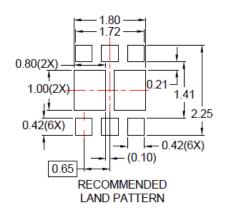
Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Dimensional Outline and Pad Layout









NOTES:

- A. CONFORM TO JADEC REGISTRATIONS MO-229, VARIATION VCCC, EXCEPT WHERE NOTED.
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
- D. LAND PATTERN RECOMMENDATION IS EXISTING INDUSTRY LAND PATTERN.
- E. DRAWING FILENAME: MKT-UMLP16Erev4
- F. NON-JEDEC DUAL DAP



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